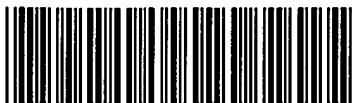


**Search Notes**

Application/Control No.

10/624,574

Examiner

M. Lee

Applicant(s)/Patent under  
Reexamination

JUNG ET AL.

Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner
348	448, 449, 451, 452	3/21/2006	ML
	441		
	458		
	459		
	699		
	700		
H04N	7/01		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference history search printout		3/12/2006	ML

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	3/21/2006	ML